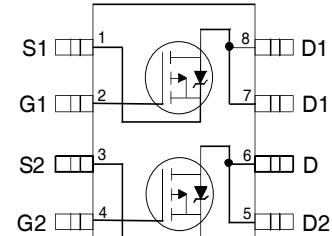


## Features

- $V_{DS} (V) = -30V$
- $R_{DS(ON)} < 58m\Omega$  ( $V_{GS} = -10V$ )
- $R_{DS(ON)} < 98m\Omega$  ( $V_{GS} = -4.5V$ )
- Generation V Technology
- Ultra Low On-Resistance
- Surface Mount
- Fully Avalanche Rated
- Lead-Free



Top View

## Description

The SOP-8 has been modified through a customized leadframe for enhanced thermacharacteristics and multiple die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques.

## Absolute Maximum Ratings ( $T_A = 25^\circ C$ Unless Otherwise Noted)

		Symbol	Maximum	Units
Drain-Source Voltage		$V_{DS}$	-30	V
Gate-Source Voltage		$V_{GS}$	$\pm 20$	
Continuous Drain Current <sup>⑤</sup>	$T_A = 25^\circ C$	$I_D$	-4.9	A
	$T_A = 70^\circ C$		-3.9	
Pulsed Drain Current		$I_{DM}$	-30	
Continuous Source Current (Diode Conduction)		$I_S$	-2.5	
Maximum Power Dissipation <sup>⑤</sup>	$T_A = 25^\circ C$	$P_D$	2.0	W
	$T_A = 70^\circ C$		1.3	
Single Pulse Avalanche Energy		$E_{AS}$	140	mJ
Avalanche Current		$I_{AR}$	-2.8	A
Repetitive Avalanche Energy		$E_{AR}$	0.20	mJ
Peak Diode Recovery dv/dt <sup>③</sup>		dv/dt	-5.0	V/ns
Junction and Storage Temperature Range		$T_J, T_{STG}$	-55 to + 150	°C

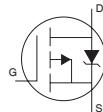
## Thermal Resistance Ratings

Parameter	Symbol	Limit	Units
Maximum Junction-to-Ambient <sup>⑤</sup>	$R_{θJA}$	62.5	°C/W

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

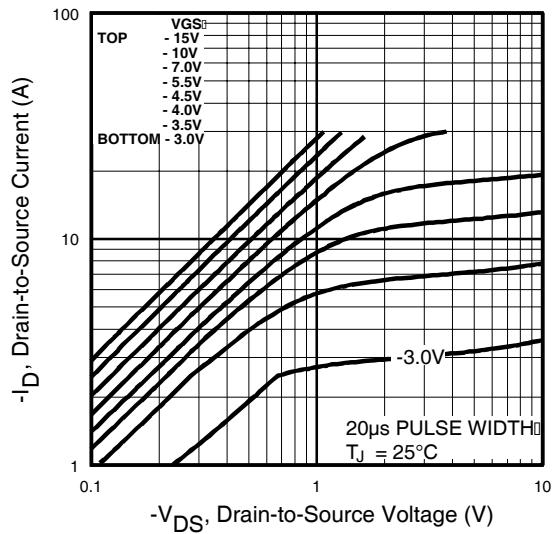
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-30			V	$V_{GS} = 0V, I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.022		V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = -1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	42	60		m $\Omega$	$V_{GS} = -10V, I_D = -4.9\text{A}$ ④
		77	100			$V_{GS} = -4.5V, I_D = -3.6\mu\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	-1.0			V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
$g_f$	Forward Transconductance		7.7		S	$V_{DS} = -15V, I_D = -4.9\text{A}$
$I_{DSS}$	Drain-to-Source Leakage Current			-1.0	$\mu\text{A}$	$V_{DS} = -24V, V_{GS} = 0V$
				-25		$V_{DS} = -24V, V_{GS} = 0V, T_J = 55^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = -20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = 20V$
$Q_g$	Total Gate Charge		23	34	nC	$I_D = -4.9\text{A}$
$Q_{gs}$	Gate-to-Source Charge		3.8	5.7		$V_{DS} = -15V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		5.9	8.9		$V_{GS} = -10V$ , See Fig. 10 ④
$t_{d(on)}$	Turn-On Delay Time	13	19		ns	$V_{DD} = -15V$
$t_r$	Rise Time	13	20			$I_D = -1.0\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	34	51			$R_G = 6.0\Omega$
$t_f$	Fall Time	32	48			$R_D = 15\Omega$ ④
$C_{iss}$	Input Capacitance	710			pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	380				$V_{DS} = -25V$
$C_{rss}$	Reverse Transfer Capacitance	180				$f = 1.0\text{MHz}$ , See Fig. 5

**Source-Drain Ratings and Characteristics**

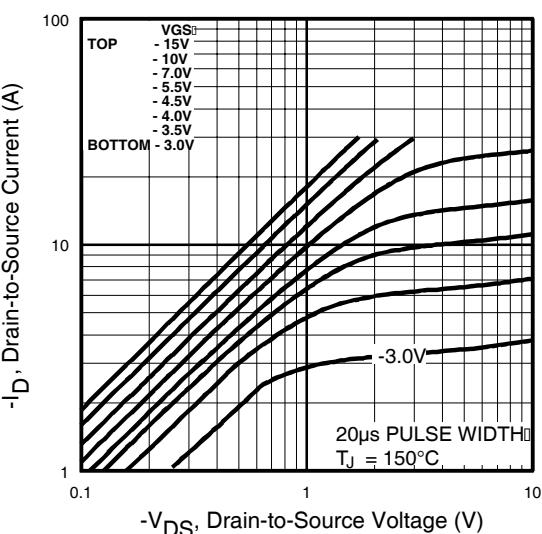
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)			-2.5	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①			-30		
$V_{SD}$	Diode Forward Voltage		-0.78	-1.0	V	$T_J = 25^\circ\text{C}, I_S = -1.7\text{A}, V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time		44	66	ns	$T_J = 25^\circ\text{C}, I_F = -1.7\text{A}$
$Q_{rr}$	Reverse Recovery Charge		42	63	nC	$di/dt = 100\text{A}/\mu\text{s}$ ③

**Notes:**

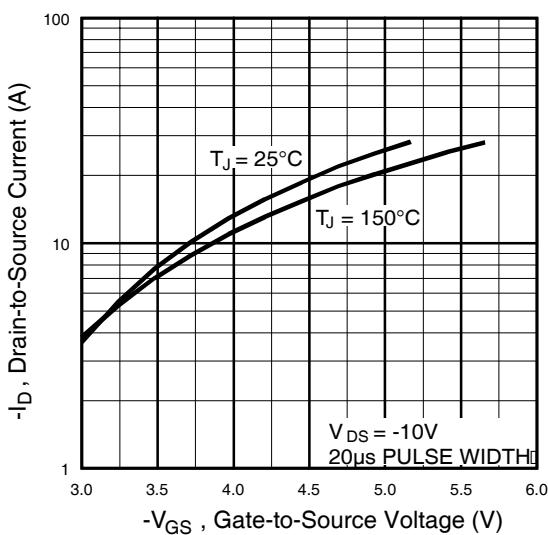
- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 35\text{mH}$   
 $R_G = 25\Omega, I_{AS} = -2.8\text{A}$ .
- ③  $I_{SD} \leq -2.8\text{A}$ ,  $di/dt \leq 150\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  
 $T_J \leq 150^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .



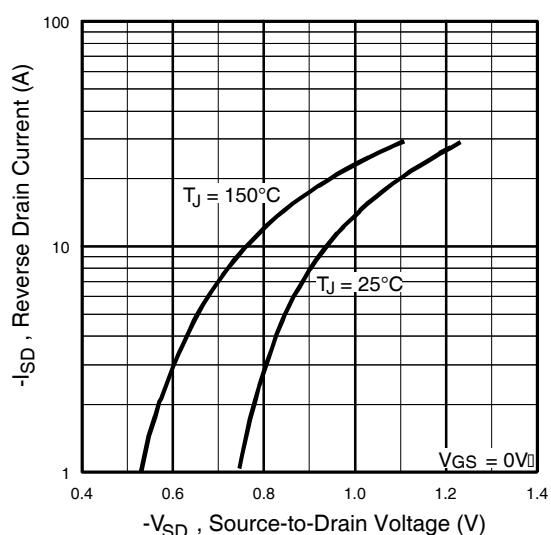
**Fig 1.** Typical Output Characteristics



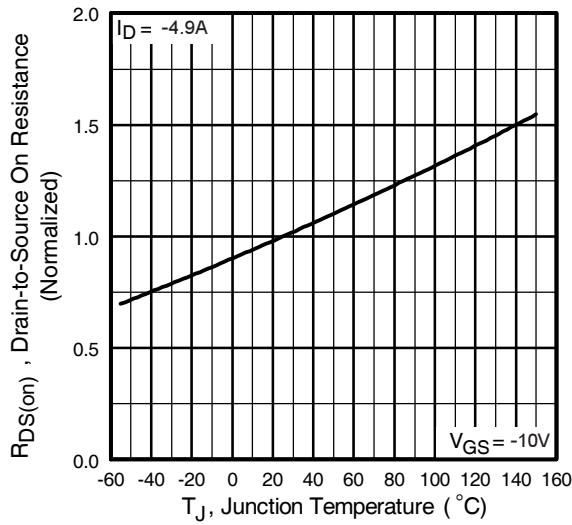
**Fig 2.** Typical Output Characteristics



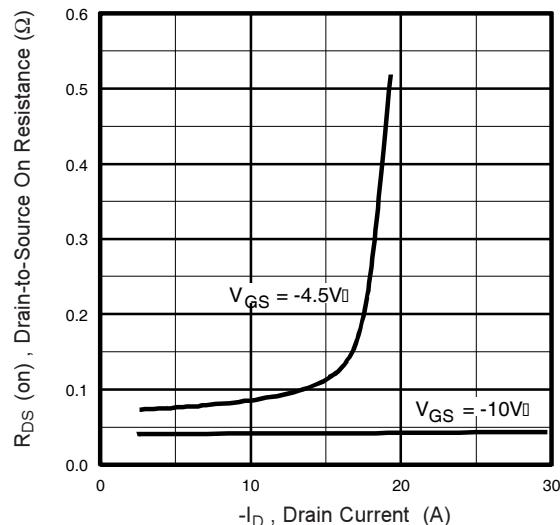
**Fig 3.** Typical Transfer Characteristics



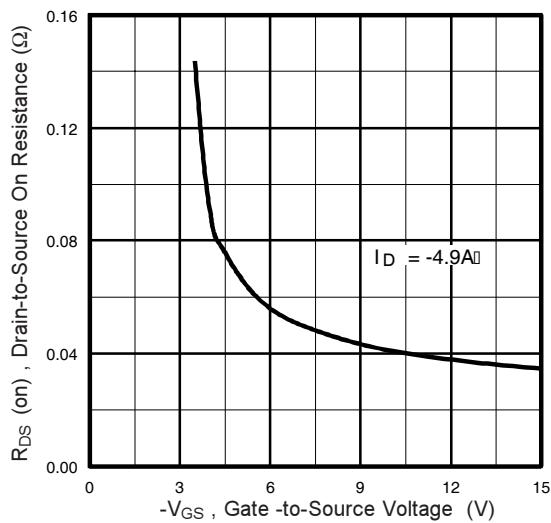
**Fig 4.** Typical Source-Drain Diode Forward Voltage



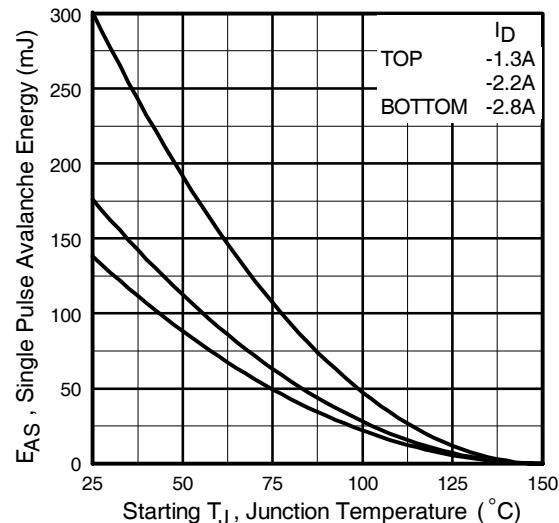
**Fig 5.** Normalized On-Resistance Vs. Temperature



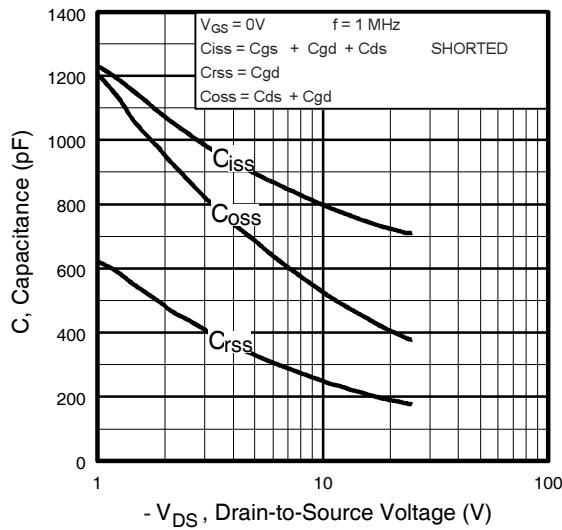
**Fig 6.** Typical On-Resistance Vs. Drain Current



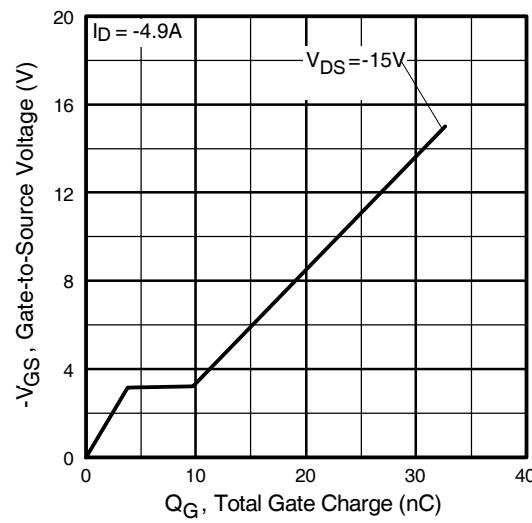
**Fig 7.** Typical On-Resistance Vs. Gate Voltage



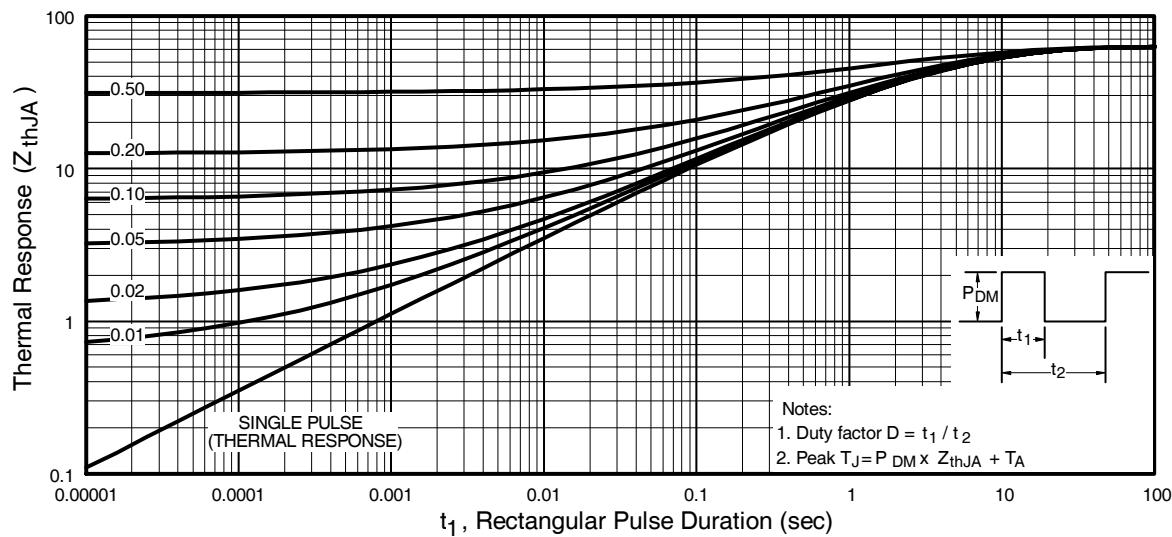
**Fig 8.** Maximum Avalanche Energy Vs. Drain Current



**Fig 9.** Typical Capacitance Vs.  
Drain-to-Source Voltage

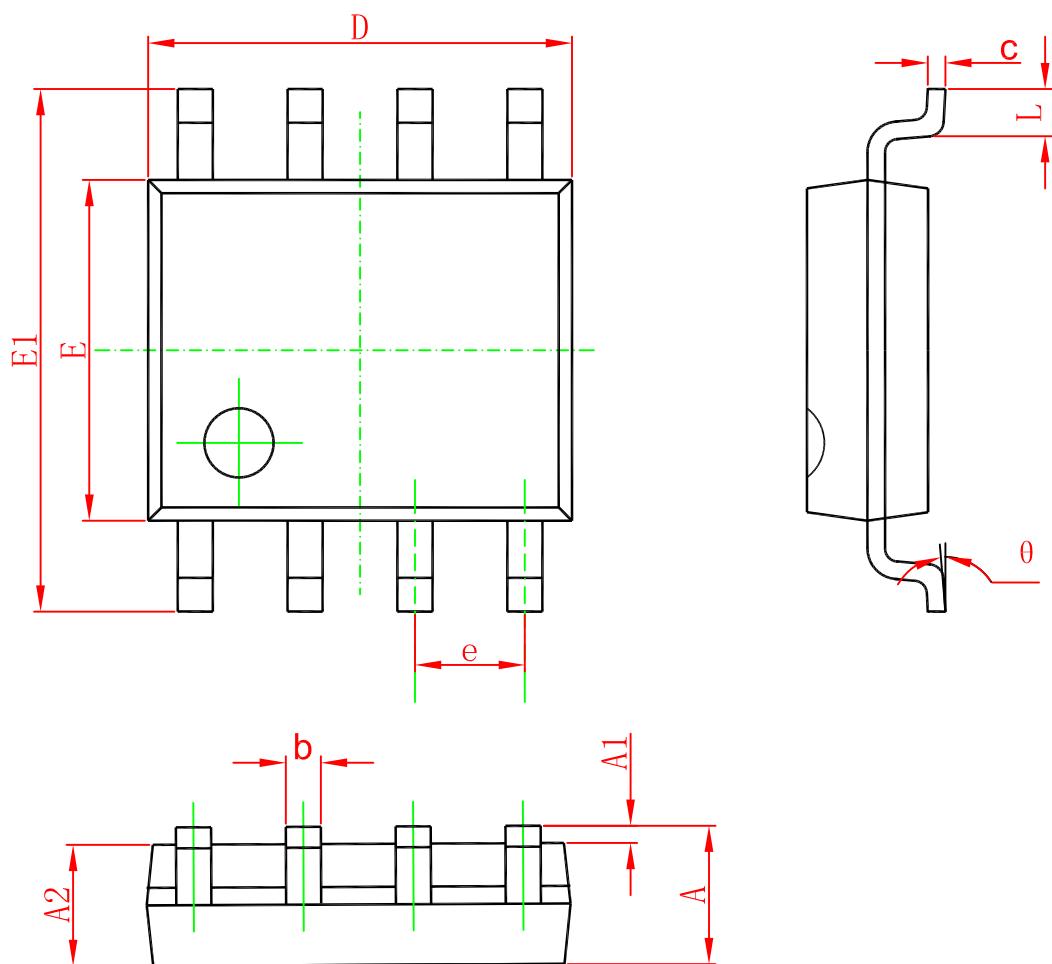


**Fig 10.** Typical Gate Charge Vs.  
Gate-to-Source Voltage

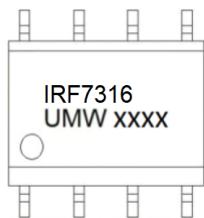


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

SOP-8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

**Marking****Ordering information**

Order code	Package	Baseqty	Deliverymode
UMW IRF7316TR	SOP-8	3000	Tape and reel